

**Group leader**  
**Roman Pöschl**

**Physics studies**

J. Rouëné, F. Richard, D.  
Zerwas, E. Kou

**Detector R&D**

Tests of electronics  
Ecal: J. Rouëné,  
T. Frisson (→2013)

Integration Ecal:  
J. Bonis (SDTM),  
A. Thiebault (SDTM)  
P. Cornebise (SERDI)

Integration ILD:  
C. Bourgeois (SDTM),  
A. Gonnin (SDTM)

**Algorithms and beam  
Test analysis**

N. van der Kolk, B Kegl